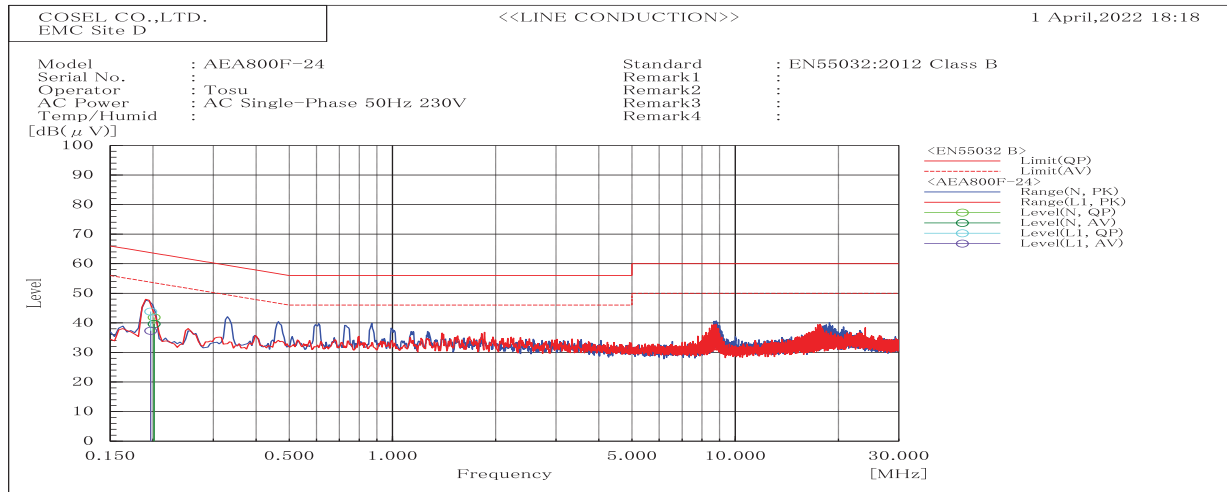
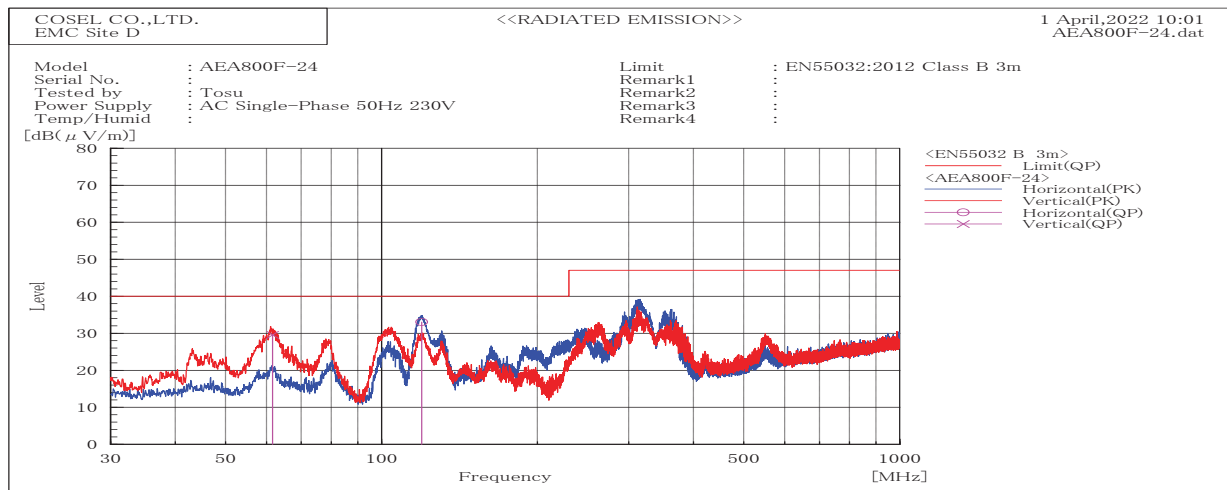


DATA SHEET		Date	05-Sep-22
Model	AEA800F-24	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	M.Tosu



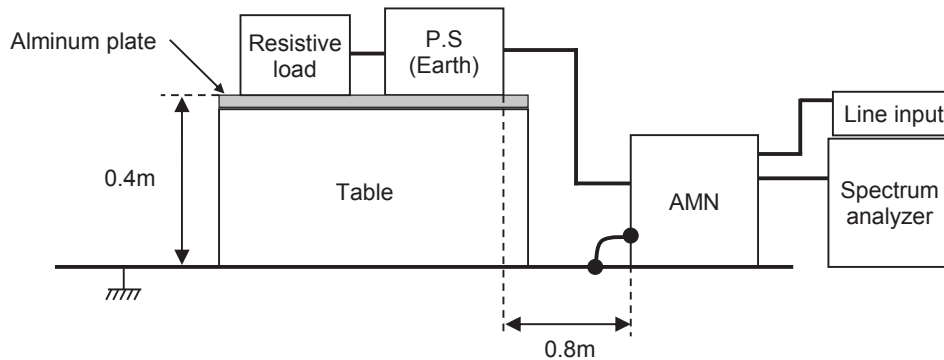
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.197	L1	43.8	37.3	63.7	53.7	19.9	16.4	Pass	
0.202	N	41.9	39.6	63.5	53.5	21.6	13.9	Pass	



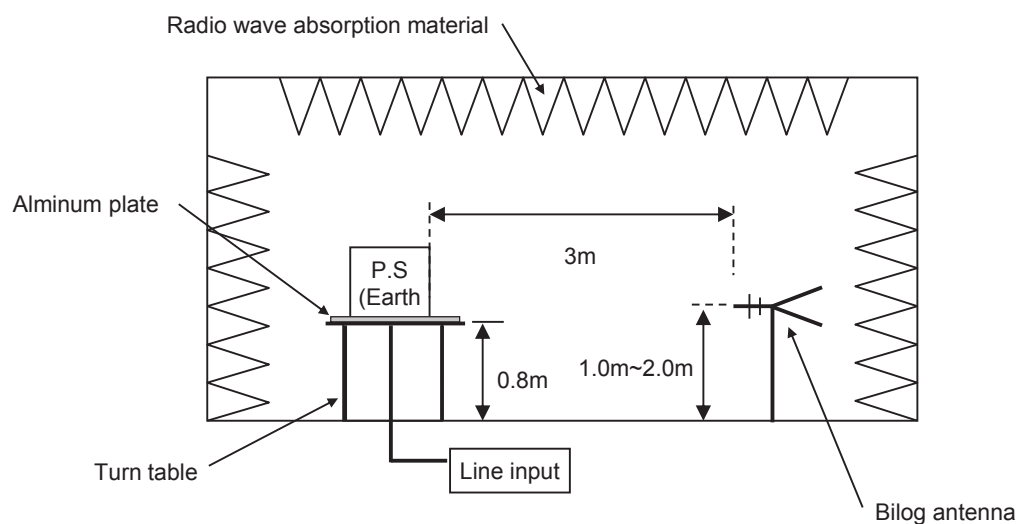
Frequency MHz	Polarization	Stability	Level dB(μV/m)	Limit dB(μV/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP	QP				
61.649	V	Stable	29.6	40	10.4	Pass	100	186.4	
119.51	H	Stable	33.1	40	6.9	Pass	199.7	166.1	

DATA SHEET		Date	05-Sep-22
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	M.Tosu

### 1. Line conduction



### 2. Radiated emission



## Conditions

Test : EMI  
Model Name: AEA800F-24

## Photographs of Test Set-Up

### 1.LINE CONDUCTION



### 2.RADIATED EMISSION

